

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/839,055	DEBBINS ET AL.	
Examiner		Art Unit		Page 1 of 1
Mary J. Steelman		2122		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,235,510	08-1993	Yamada et al.	600/300
	B	US-5,668,998	09-1997	Mason et al.	717/104
	C	US-5,850,548	12-1998	Williams, David Mark	717/107
	D	US-5,950,002	09-1999	Hoford et al.	717/109
	E	US-6,157,194	12-2000	Vassallo et al.	324/322
	F	US-6,279,030 B1	08-2001	Britton et al.	709/203
	G	US-6,282,699 B1	08-2001	Zhang et al.	717/109
	H	US-6,718,533 B1	04-2004	Schneider et al.	717/100
	I	US-2002/0029376 A1	03-2002	Ambrose et al.	717/113
	J	US-2002/0113590 A1	08-2002	Haworth et al.	324/309
	K	US-2003/0039392 A1	02-2003	Eckstein, Wolfgang	382/168
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Atkins, M.S., "Role of Visual Languages in Developing Image Analysis Algorithms", Zuk, T., Johnston, B., & Arden, T., p. 262-268, 1994 IEEE [retired 06/22/2004].
	V	"About Coreco - Brief History", release 06/18/2001, 2 pages [retrieved 06/22/2004] Retrieved from the Internet: <URL: http://www.coreco.com/Web/home.nst/0/8467af9ed556f1c185268c100718a8a?OpenDocument&Lang=Gb >.
	W	National Instruments, "Vision Applications growing for Computer-Based Vision Measurements", 1999, 2 pages [retrieved 06/22/2004] Retrieved from the Internet: <URL: http://www.tinkersguild.com/sample/SponsorAds/Natinstruments/vision_basics.htm >.
	X	GlobalSpec.com, "WiT 8.0", 1999-2004, 2 pages [retrieved 06/22/2004] Retrieved from the Internet: <URL: http://www.globalspec.com/FeaturedProducts/Detail?ExhibitD=9976 >.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.